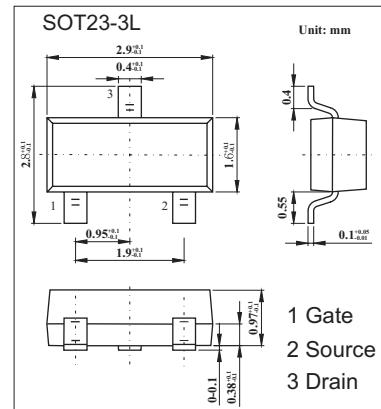
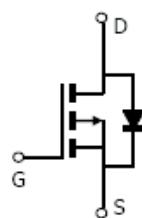


### ■ Features

- $V_{DS}$  (V) = -30V
- $I_D$  = -2.6 A ( $V_{GS}$  = -10V)
- $R_{DS(ON)} < 130\text{m}\Omega$  ( $V_{GS}$  = -10V)
- $R_{DS(ON)} < 200\text{m}\Omega$  ( $V_{GS}$  = -4.5V)



### ■ Absolute Maximum Ratings $T_a = 25^\circ\text{C}$

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	$V_{DS}$	-30	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current $T_a=25^\circ\text{C}$	$I_D$	-2.6	A
$T_a=70^\circ\text{C}$		-2.2	
Pulsed Drain Current	$I_{DM}$	-20	
Power Dissipation $T_a=25^\circ\text{C}$	$P_D$	1.4	W
$T_a=70^\circ\text{C}$		1	
Thermal Resistance. Junction-to-Ambient	$R_{thJA}$	100	$^\circ\text{C}/\text{W}$
Thermal Resistance. Junction-to-Case	$R_{thJC}$	63	$^\circ\text{C}/\text{W}$
Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 to 150	$^\circ\text{C}$

■ Electrical Characteristics Ta = 25°C

Parameter	Symbol	Testconditons	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	V <sub>DSS</sub>	I <sub>D</sub> =250 µ A, V <sub>GS</sub> =0V	-30			V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>D</sub> =-24V, V <sub>GS</sub> =0V			-1	µ A
		V <sub>D</sub> =-24V, V <sub>GS</sub> =0V, TJ=55°C			-5	
Gate-Body leakage current	I <sub>GSS</sub>	V <sub>D</sub> =0V, V <sub>GS</sub> =±20V			±100	nA
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>D</sub> =V <sub>GS</sub> I <sub>D</sub> =-250 µ A	-1	-1.9	-3	V
Static Drain-Source On-Resistance	r <sub>D(on)</sub>	V <sub>GS</sub> =-10V, I <sub>D</sub> =-2.6A		97	130	mΩ
		V <sub>GS</sub> =-10V, I <sub>D</sub> =-2.6A TJ=125°C		135	150	
		V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-2A		166	200	
On state drain current	I <sub>D(on)</sub>	V <sub>GS</sub> =-4.5V, V <sub>D</sub> =-5V	-5			A
Forward Transconductance	g <sub>fs</sub>	V <sub>D</sub> =-5V, I <sub>D</sub> =-5A	3	3.8		S
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> =0V, V <sub>D</sub> =-15V, f=1MHz		302	370	pF
Output Capacitance	C <sub>oss</sub>			50.3		pF
Reverse Transfer Capacitance	C <sub>rss</sub>			37.8		pF
Gate resistance	R <sub>g</sub>	V <sub>GS</sub> =0V, V <sub>D</sub> =0V, f=1MHz		12	18	Ω
Total Gate Charge (10V)	Q <sub>g</sub>	V <sub>GS</sub> =-4.5V, V <sub>D</sub> =-15V, I <sub>D</sub> =-2.6A		6.8	9	nC
Total Gate Charge (4.5V)				2.4		nC
Gate Source Charge	Q <sub>gs</sub>			1.6		nC
Gate Drain Charge	Q <sub>gd</sub>			0.95		nC
Turn-On DelayTime	t <sub>D(on)</sub>	V <sub>GS</sub> =-10V, V <sub>D</sub> =-15V, R <sub>L</sub> =5.8 Ω, R <sub>GEN</sub> =3 Ω		7.5		ns
Turn-On Rise Time	t <sub>r</sub>			3.2		ns
Turn-Off DelayTime	t <sub>D(off)</sub>			17		ns
Turn-Off Fall Time	t <sub>f</sub>			6.8		ns
Body Diode Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> =-2.6A, dI/dt=100A/µ s		16.8	22	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> =-2.6A, dI/dt=100A/µ s		10		nC
Maximum Body-Diode Continuous Current	I <sub>s</sub>				-2	A
Diode Forward Voltage	V <sub>SD</sub>	I <sub>s</sub> =-1A, V <sub>GS</sub> =0V		-0.82	-1	V

\* Repetitive rating, pulse width limited by junction temperature.

### ■ Typical Characteristics

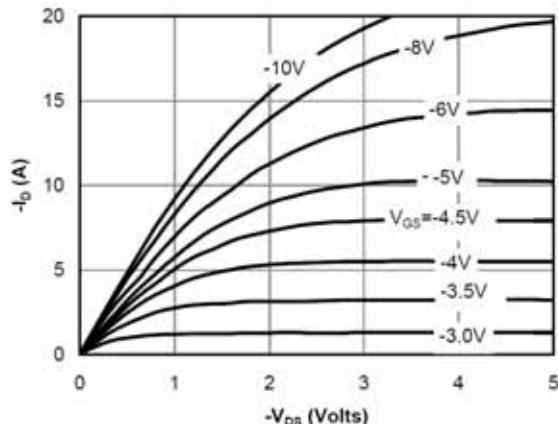


Fig 1: On-Region Characteristics

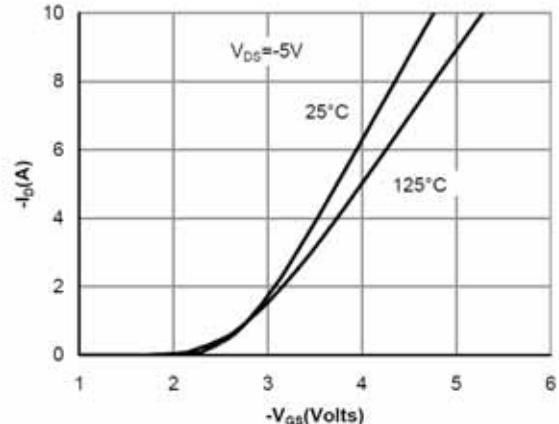


Figure 2: Transfer Characteristics

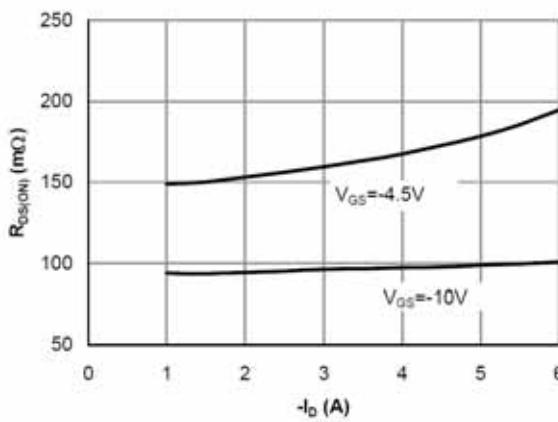


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

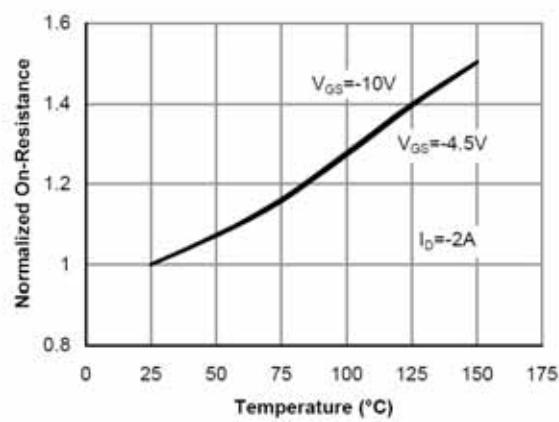


Figure 4: On-Resistance vs. Junction Temperature

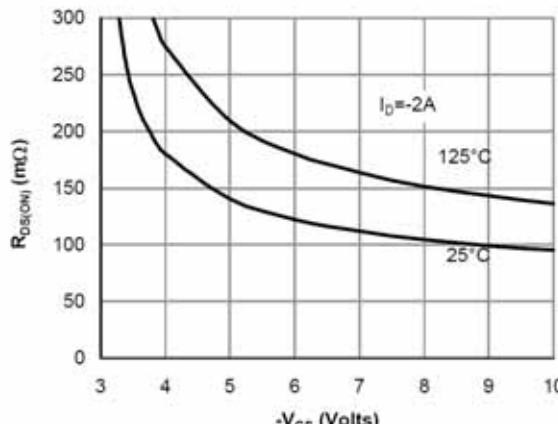


Figure 5: On-Resistance vs. Gate-Source Voltage

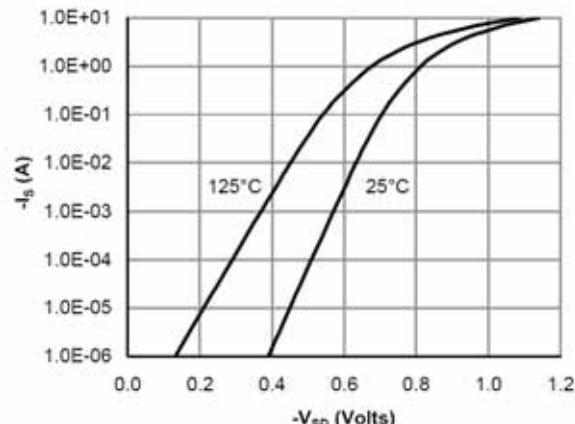


Figure 6: Body-Diode Characteristics

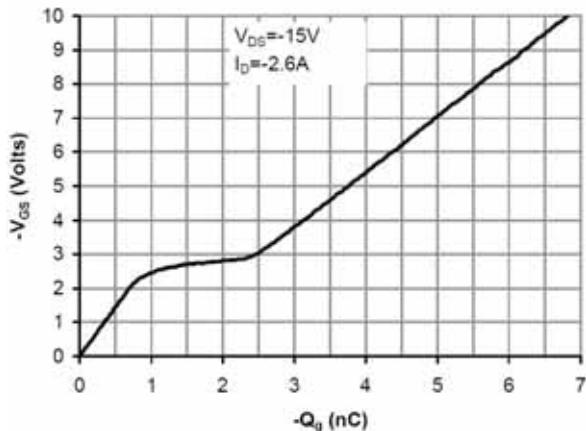


Figure 7: Gate-Charge Characteristics

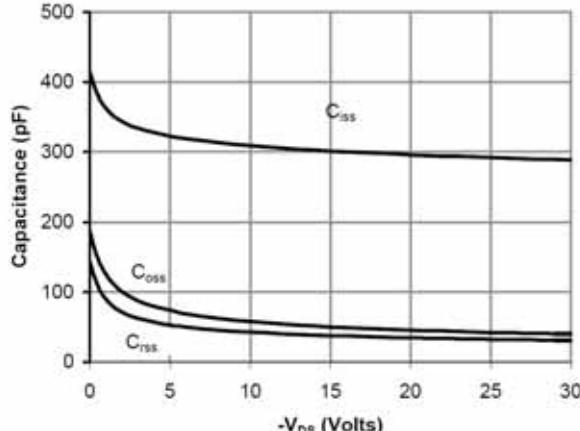


Figure 8: Capacitance Characteristics

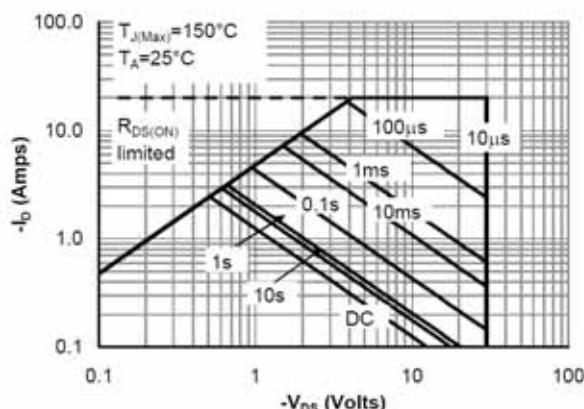


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

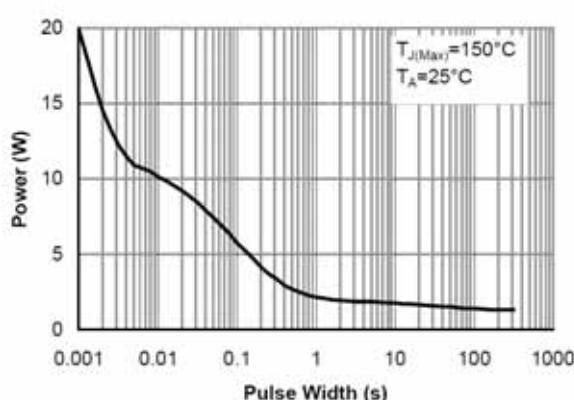


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

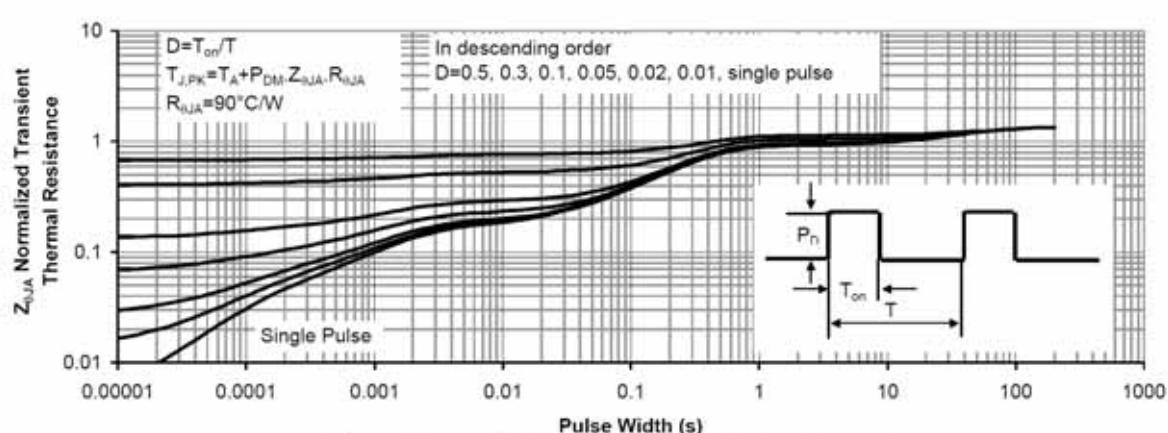


Figure 11: Normalized Maximum Transient Thermal Impedance